

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10018355	KITANO ET AL.
Examiner	Art Unit	
AARON M RICHER	2628	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB) - updated - see search history	8/19/08	AMR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner